IGBT

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop (FS) Trench construction, and provides superior performance in demanding switching applications, offering both low on state voltage and minimal switching loss. The IGBT is well suited for half bridge resonant applications. Incorporated into the device is a soft and fast co–packaged free wheeling diode with a low forward voltage.

Features

- Extremely Efficient Trench with Fieldstop Technology
- Low Switching Loss Reduces System Power Dissipation
- Optimized for Low Losses in IH Cooker Application
- $T_{Jmax} = 175^{\circ}C$
- Soft, Fast Free Wheeling Diode
- This is a Pb-Free Device

Typical Applications

- Inductive Heating
- Soft Switching

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-emitter voltage	V_{CES}	650	V
Collector current @ Tc = 25°C @ Tc = 100°C	I _C	60 30	A
Pulsed collector current, T _{pulse} limited by T _{Jmax}	I _{CM}	120	Α
Diode forward current @ Tc = 25°C @ Tc = 100°C	l _F	60 30	A
Diode pulsed current, T _{pulse} limited by T _{Jmax}	I _{FM}	120	Α
Gate-emitter voltage	V_{GE}	±20	V
Power Dissipation @ Tc = 25°C @ Tc = 100°C	P _D	300 150	W
Operating junction temperature range	TJ	–55 to +175	°C
Storage temperature range	T _{stg}	-55 to +175	°C
Lead temperature for soldering, 1/8" from case for 5 seconds	T _{SLD}	260	°C

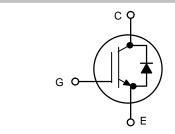
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

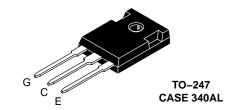


ON Semiconductor®

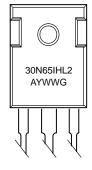
http://onsemi.com

30 A, 650 V $V_{CEsat} = 1.6 V$ $E_{off} = 0.2 mJ$





MARKING DIAGRAM



A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
NGTB30N65IHL2WG	TO-247 (Pb-Free)	30 Units / Rail

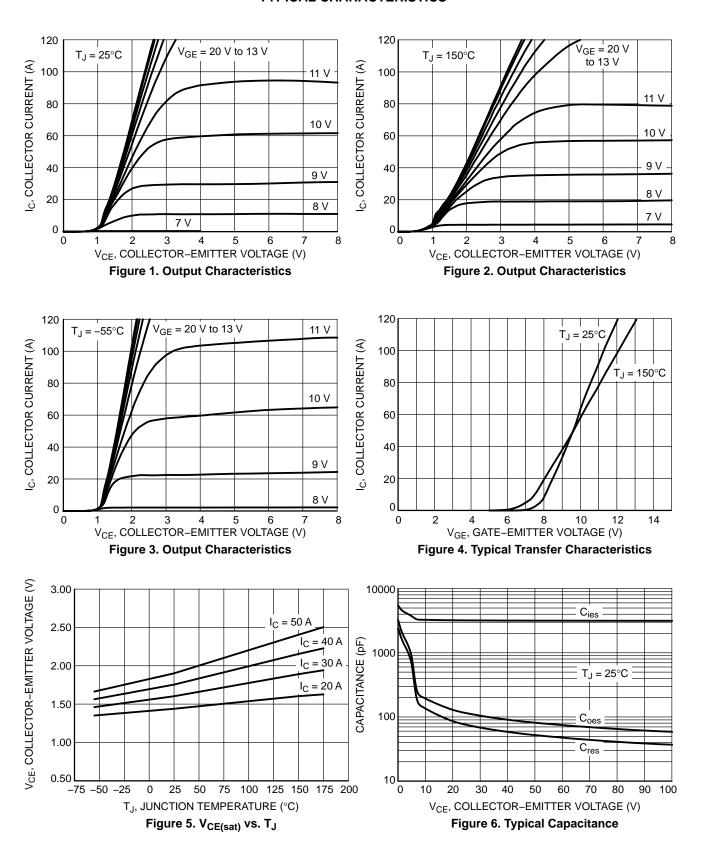
THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{ heta JC}$	0.50	°C/W
Thermal resistance junction-to-case, for Diode	$R_{ heta JC}$	1.46	°C/W
Thermal resistance junction-to-ambient	$R_{ heta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
STATIC CHARACTERISTIC				<u></u>	I	
Collector–emitter breakdown voltage, gate–emitter short–circuited	$V_{GE} = 0 \text{ V}, I_{C} = 500 \mu\text{A}$	V _{(BR)CES}	650	_	-	V
Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 30 A V _{GE} = 15 V, I _C = 30 A, T _J = 175°C	V _{CEsat}	-	1.6 2.0	2.2 -	V
Gate-emitter threshold voltage	V _{GE} = V _{CE} , I _C = 150 μA	$V_{GE(th)}$	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate- emitter short-circuited	V _{GE} = 0 V, V _{CE} = 650 V V _{GE} = 0 V, V _{CE} = 650 V, T _J = 175°C	I _{CES}	-	- -	0.2 2	mA
Gate leakage current, collector–emitter short–circuited	V _{GE} = 20 V , V _{CE} = 0 V	I _{GES}	-	-	100	nA
DYNAMIC CHARACTERISTIC						
Input capacitance		C _{ies}	-	3200	_	pF
Output capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	C _{oes}	-	130	_	1
Reverse transfer capacitance	1	C _{res}	-	85	_	
Gate charge total		Q_g		135		nC
Gate to emitter charge	$V_{CE} = 480 \text{ V}, I_{C} = 30 \text{ A}, V_{GE} = 15 \text{ V}$	Q _{ge}		26		1
Gate to collector charge	1	Q _{gc}		66		
SWITCHING CHARACTERISTIC, INDUC	TIVE LOAD					
Turn-off delay time	$T_J = 25^{\circ}\text{C}$ $V_{CC} = 400 \text{ V, } I_C = 30 \text{ A}$ $R_g = 10 \Omega$ $V_{GE} = 0 \text{ V/ } 15 \text{V}$	t _{d(off)}		145		ns
Fall time		t _f		71		1
Turn-off switching loss		E _{off}		0.2		mJ
Turn-off delay time	$T_J = 150^{\circ}\text{C}$ $V_{CC} = 400 \text{ V, } I_C = 30 \text{ A}$ $R_g = 10 \Omega$ $V_{GE} = 0 \text{ V/ } 15 \text{ V}$	t _{d(off)}		151		ns
Fall time		t _f		94		1
Turn-off switching loss		E _{off}		0.41		mJ
DIODE CHARACTERISTIC						
Forward voltage	V _{GE} = 0 V, I _F = 30 A V _{GE} = 0 V, I _F = 30 A, T _J = 175°C	V _F		1.1 1.0	1.3	V
Reverse recovery time	$T_J = 25^{\circ}C$ $I_F = 30 \text{ A, V}_R = 200 \text{ V}$ $di_F/dt = 200 \text{ A/}\mu\text{s}$	t _{rr}		430		ns
Reverse recovery charge		Q _{rr}		7700		nc
Reverse recovery current		I _{rrm}		35		Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



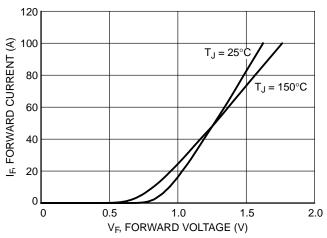


Figure 7. Diode Forward Characteristics

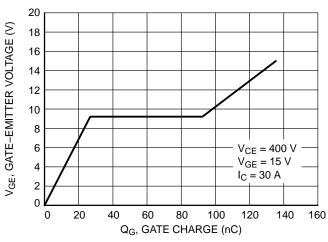


Figure 8. Typical Gate Charge

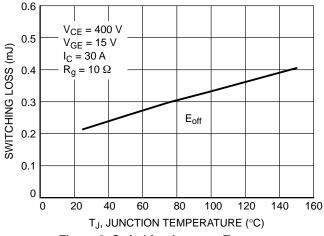


Figure 9. Switching Loss vs. Temperature

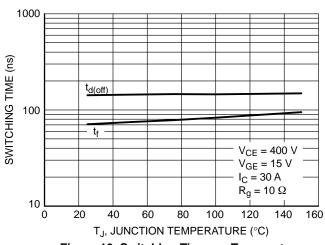


Figure 10. Switching Time vs. Temperature

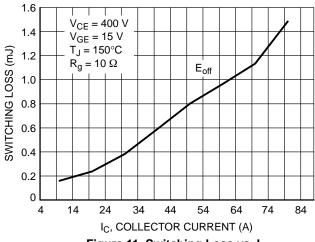


Figure 11. Switching Loss vs. I_C

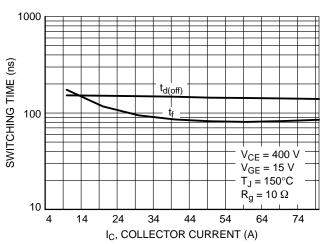


Figure 12. Switching Time vs. I_C

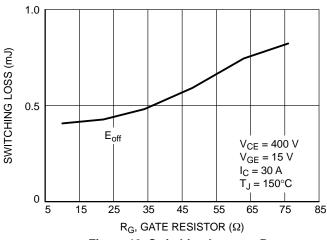


Figure 13. Switching Loss vs. $R_{\mbox{\scriptsize G}}$

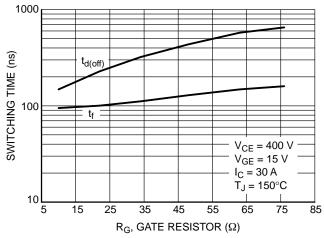


Figure 14. Switching Time vs. R_G

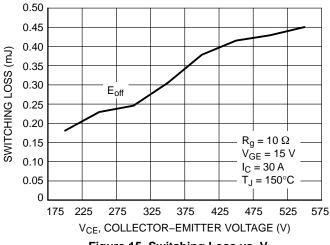


Figure 15. Switching Loss vs. V_{CE}

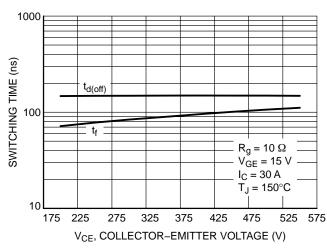
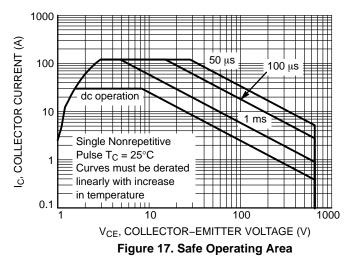


Figure 16. Switching Time vs. V_{CE}



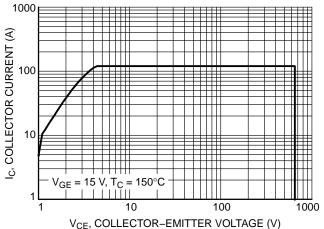


Figure 18. Reverse Bias Safe Operating Area

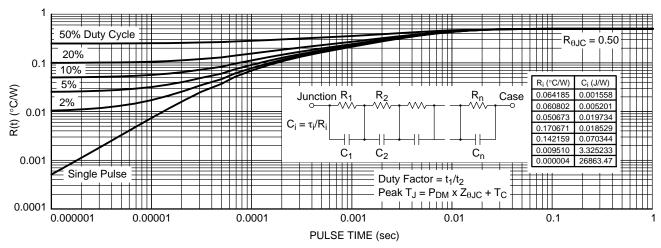


Figure 19. IGBT Transient Thermal Impedance

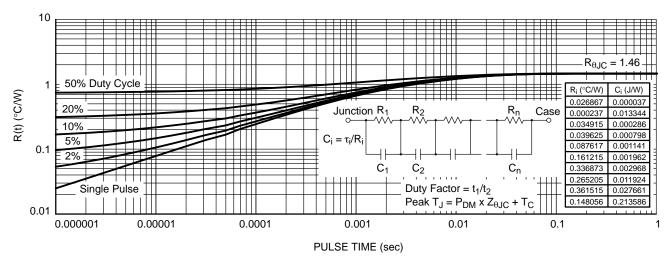
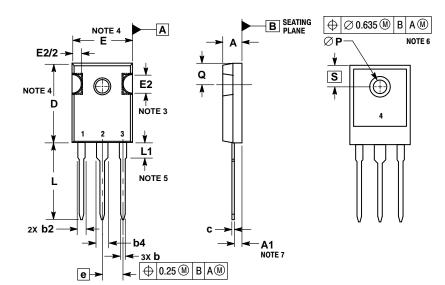


Figure 20. Diode Transient Thermal Impedance

PACKAGE DIMENSIONS

TO-247 CASE 340AL **ISSUE A**



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.

- SLOT REQUIRED, NOTCH MAY BE ROUNDED.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREME OF THE PLASTIC BODY.
- LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY
- ØP SHALL HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM DIAMETER OF 3.91.
- DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.

$\overline{}$			
	MILLIMETERS		
DIM	MIN	MAX	
Α	4.70	5.30	
A1	2.20	2.60	
b	1.00	1.40	
b2	1.65	2.35	
b4	2.60	3.40	
С	0.40	0.80	
D	20.30	21.40	
E	15.50	16.25	
E2	4.32	5.49	
е	5.45 BSC		
L	19.80	20.80	
L1	3.50	4.50	
P	3.55	3.65	
Q	5.40	6.20	
S	6.15 BSC		

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